

<b>Notice of References Cited</b>	Application/Control No. 10/565,004	Applicant(s)/Patent Under Reexamination UEHARA ET AL.	
	Examiner Keath T. Chen	Art Unit 1709	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,281,469	08-2001	Perrin et al.	219/121.43
*	B	US-6,518,990	02-2003	Koga et al.	347/141
*	C	US-2003/0079983	05-2003	Long et al.	204/164
*	D	US-4,042,848	08-1977	Lee, Ja Hyun	376/145
*	E	US-3,959,104	05-1976	Fales, John D.	204/164
*	F	US-2004/0050685	03-2004	Yara et al.	204/164
*	G	US-5,185,132	02-1993	Horiike et al.	422/186.05
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000109979	04-2000	Japan	Okui	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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